


<b>Search Notes</b>  	<b>Application/Control No.</b>  10652493	<b>Applicant(s)/Patent Under Reexamination</b>  CHOE ET AL.
	<b>Examiner</b>  SANG Y PAIK	<b>Art Unit</b>  3742

SEARCHED			
Class	Subclass	Date	Examiner
updated as searched on 10/12/06		12/24/09	sp
updated		7/1/10	sp

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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